

Form PTO-1449

U.S. DEPARTMENT OF COMMERCE
PATENT AND TRADEMARK OFFICEATTY. DOCKET NO.
M122-1246SERIAL NO.
09/517,127LIST OF ART CITED BY APPLICANT
(Use several sheets if necessary)APPLICANT
Scott E. Moore et al.FILING DATE
March 12, 2000GROUP
Unknown

U.S. PATENT DOCUMENTS

Initial	Document Number	Date	Name	Class	Subclass	Filing Date If Appropriate
JK	AA 5,755,614	05/26/98	Adams et al.			
JK	AB 5,664,990	09/09/97	Adams et al.			
	AC					
	AD					
	AE					

FOREIGN PATENT DOCUMENTS

	Document Number	Date	Country	Class	Subclass	Translation	
						Yes	No
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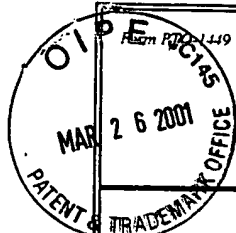
OTHER REFERENCES (including Author, Title, Date, Pertinent Pages, Etc.)

JK	AI	http://www.intratechnology.com/html/sensors.htm , Intra Technology, <i>Sensors</i> , 03/25/99, 2 pages
	AJ	http://www.ftsiinc.com/complete/analite/analite.htm , FTS, <i>Analite-SDI Turbidity Sensor</i> , 03/25/99, 1 page
	AK	http://www.customsensors.com/optimax.htm , Custom Sensors & Technology, <i>OptiMax 6000 Series Process Photometric Analyzers</i> , 03/25/99, 2 pages
	AL	http://www.reflectronics.com/reflectronics_inc_contents.htm , Reflectronics, Inc., <i>Fiber Optic Backscatter Sensor</i> , 03/25/99, 1 page
	AM	http://www.honeywell.com/sensing/prodinfo/turbidity/technical/turbidity.st , Gary O'Brien, Honeywell, <i>Turbidity Sensor for Electromechanical Dishwasher Control</i> , 1998-1999, 11 pages
JK	AT	http://www.imponag.com/O_automa/10970064.htm , ABB Instrumentation, <i>The Stockroom, Photodiode Sensor</i> , 1999, 1 page

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TK	AI		"The Science and Engineering of Microelectronic Fabrication"; Campbell, Stephen A.; Oxford University Press; 1996; pp. 253-257.
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JS	AA	5,755,614	05/26/98	Adams et al.			
TR	AB	5,664,990	09/09/97	Adams et al.			
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TR	AI		http://www.intratechnology.com/html/sensors.htm , Intra Technology, <i>Sensors</i> , 03/25/99, 2 pages
	AJ		http://www.ftisinc.com/complete/analite/analite.htm , FTS, <i>Analite-SDI Turbidity Sensor</i> , 03/25/99, 1 page
	AK		http://www.customsensors.com/optimax.htm , Custom Sensors & Technology, <i>OptiMax 6000 Series Process Photometric Analyzers</i> , 03/25/99, 2 pages
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	AM		http://www.honeywell.com/sensing/prodinfo/turbidity/technical/turbidity.st , Gary O'Brien, Honeywell, <i>Turbidity Sensor for Electromechanical Dishwasher Control</i> , 1998-1999, 11 pages
TR	AT		http://www.impomag.com/O_automa/1097O064.htm , ABB Instrumentation, <i>The Stockroom, Photodiode Sensor</i> , 1999, 1 page

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March 12, 2000GROUP
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U.S. PATENT AND TRADEMARK OFFICE

*Examiner Initial		Document Number	Date	Name	Class	Subclass	Filing Date If Appropriate
TR	AA	5,836,805	11/17/98	Obeng			
	AB	6,066,030	5/23/00	Uzoh			
	AC	6,077,147	6/20/00	Yang et al.			
	AD	6,048,256	4/11/00	Obeng et al.			
TR	AE	5,653,624	8/5/97	Ishikawa et al.			
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							Yes	No
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